

Symbol	Parameter		Ratings	Units		
V _{DS}	Drain to Source Voltage	100	V			
V _{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T _C = 25°C	(Note 5)	200		
I _D	-Continuous	T _C = 100°C	(Note 5)	140	Α	
	-Pulsed		(Note 4)	1000		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	866	mJ	
P _D	Power Dissipation	T _C = 25°C		250	w	
	Power Dissipation	T _A = 25°C	(Note 1a)	3.5	vv	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	0.6	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	43	C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDBL0260N100	FDBL0260N100	MO-299A	-	-	-

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Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	100			V
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		53		mV/°C
IDSS	Zero Gate Voltage Drain Current	V _{DS} = 80 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20 V, V _{DS} = 0 V			±100	nA
	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V_{GS} = V_{DS} , I_D = 250 μ A	2	2.7	4	V
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 80 A		2.1	2.6	mΩ
$rac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 $\mu A,$ referenced to 25 °C		-13		mV/°C
	Forward Transconductance	V _{DS} = 10 V, I _D = 80 A		170		S
	Characteristics	V _{DS} - 10 V, I _D - 60 A		170		3
Dynamic C _{iss} C _{oss}	Characteristics Input Capacitance Output Capacitance	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 80 \text{ A}$ 		6175 1330	9265 1995	pF pF
Dynamic C _{iss} C _{oss} C _{rss}	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		6175 1330 40		pF pF pF
Dynamic C _{iss} C _{oss} C _{rss}	Characteristics Input Capacitance Output Capacitance			6175 1330	1995	pF pF
Dynamic C _{iss} C _{oss} C _{rss} R _g	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		6175 1330 40	1995	pF pF pF
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		6175 1330 40	1995	pF pF pF
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		6175 1330 40 2.6	1995 60	pF pF pF Ω
Dynamic C _{iss} C _{oss} C _{rss} R _g Switching t _{d(on)} t _r	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time	$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHz V_{GS} = 0.5V, f = 1MHz		6175 1330 40 2.6 26	1995 60 42	pF pF pF Ω
Dynamic C_{iss} C_{oss} C_{rss} R_g Switching $t_{d(on)}$ t_r $t_{d(off)}$	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time	$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHz $V_{GS} = 0.5 \text{ V}, \text{ f} = 1 \text{ MHz}$		6175 1330 40 2.6 26 34	1995 60 42 54	pF pF pF Ω ns
Dynamic Ciss Coss Crss Rg Switching t _d (on) t _r t _d (off) t _f	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1 MHz $V_{GS} = 0.5 \text{ V}, \text{ f} = 1 \text{ MHz}$		6175 1330 40 2.6 26 34 47	1995 60 42 54 75	pF pF pF Ω ns ns
$\begin{array}{c} \textbf{Dynamic}\\ \hline \textbf{C}_{iss}\\ \hline \textbf{C}_{oss}\\ \hline \textbf{C}_{rss}\\ \hline \textbf{R}_{g}\\ \hline \textbf{Switching}\\ \hline \textbf{Switching}\\ \hline \textbf{t}_{d(on)}\\ \hline \textbf{t}_{r}\\ \hline \textbf{t}_{d(off)}\\ \hline \textbf{t}_{f}\\ \hline \textbf{Q}_{g(TOT)}\\ \hline \end{array}$	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz $V_{GS} = 0.5 \text{ V}, \text{ f} = 1 \text{ MHz}$ $V_{DD} = 50 \text{ V}, \text{ I}_{D} = 80 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		6175 1330 40 2.6 26 34 47 19	1995 60 42 54 75 34	pF pF pF Ω ns ns ns ns
C _{iss} C _{oss} C _{rss} R _g	Characteristics Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$V_{DS} = 50 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ $f = 1 \text{ MHz}$ $V_{GS} = 0.5 \text{ V}, \text{ f} = 1 \text{ MHz}$ $V_{DD} = 50 \text{ V}, \text{ I}_{D} = 80 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ to } 10 \text{ V}$		6175 1330 40 2.6 26 34 47 19 83	1995 60 42 54 75 34 116	pF pF Ω ns ns ns ns nc

Drum							
I _S	Maximum Continuous Drain to Source Dio	le Forward Current		-	-	200	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	-	1000	Α
V.	Source to Drain Diode Forward Voltage	63 . , 3	Note 2)		0.8	1.3	V
V _{SD}	Source to Drain Diode Torward voltage	$V_{GS} = 0 V, I_S = 40 A$ (I	Note 2)		0.8	1.2	v
t _{rr}	Reverse Recovery Time	- I _F = 80 A, di/dt = 100 A/μs			71	113	ns
Q _{rr}	Reverse Recovery Charge	$I_F = 80 \text{ A}, \text{ di/dt} = 100 \text{ A/} \mu \text{s}$ 121		194	nC		

Q_{rr} Notes:

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.

a) 43 $^{\circ}\text{C/W}$ when mounted on a 1 in² pad of 2 oz copper.

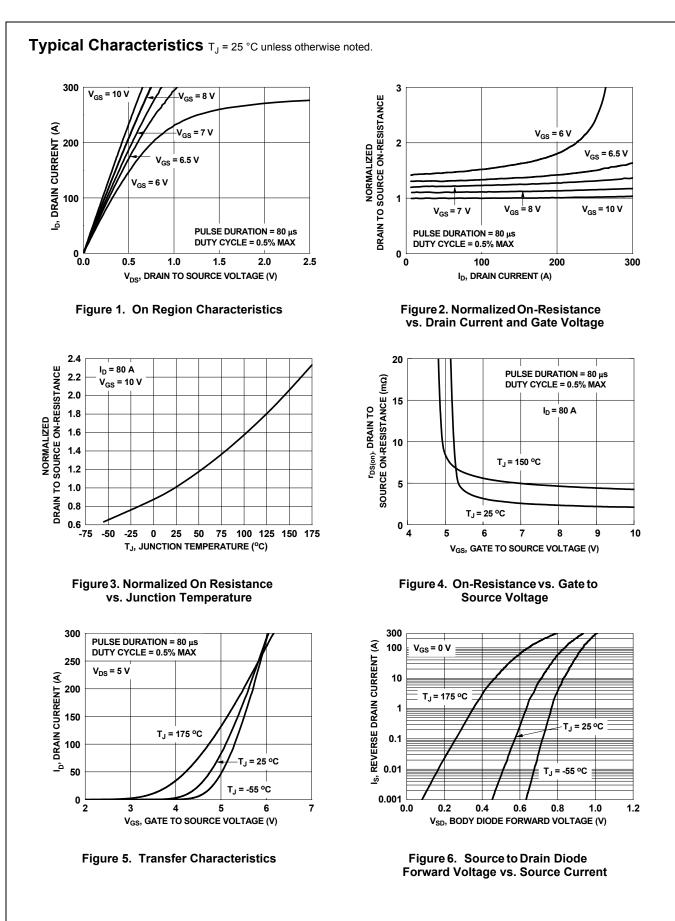
2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0 %.

3. E_{AS} of 866 mJ is based on starting T_J = 25 °C, L = 0.3 mH, I_{AS} = 76 A, V_{DD} = 90 V, V_{GS} = 10 V. 100% test at L = 0.1 mH, I_{AS} = 110 A.

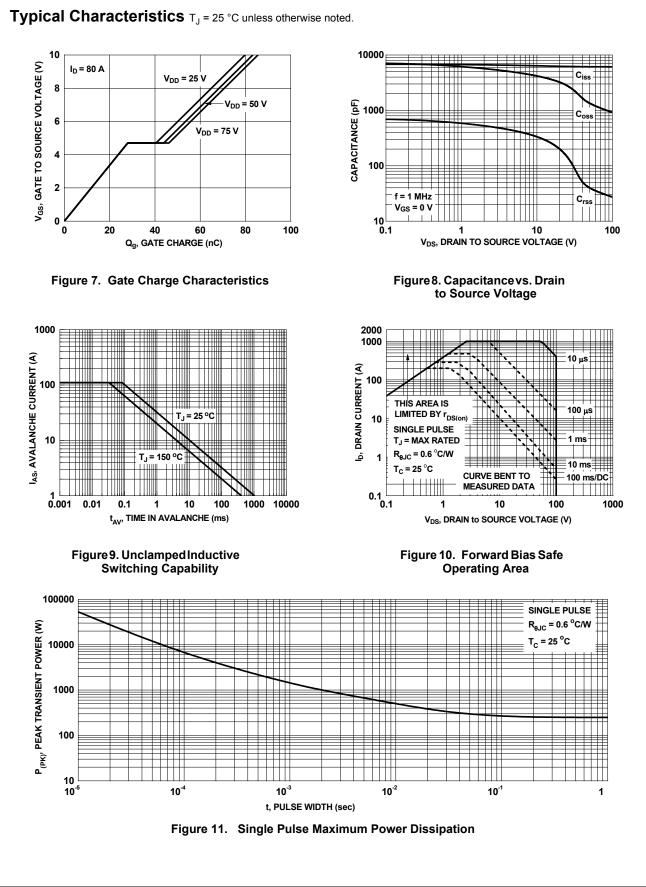
4. Pulsed Id please refer to Figure "Forward Bias Safe Operating Area" for more details.

5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

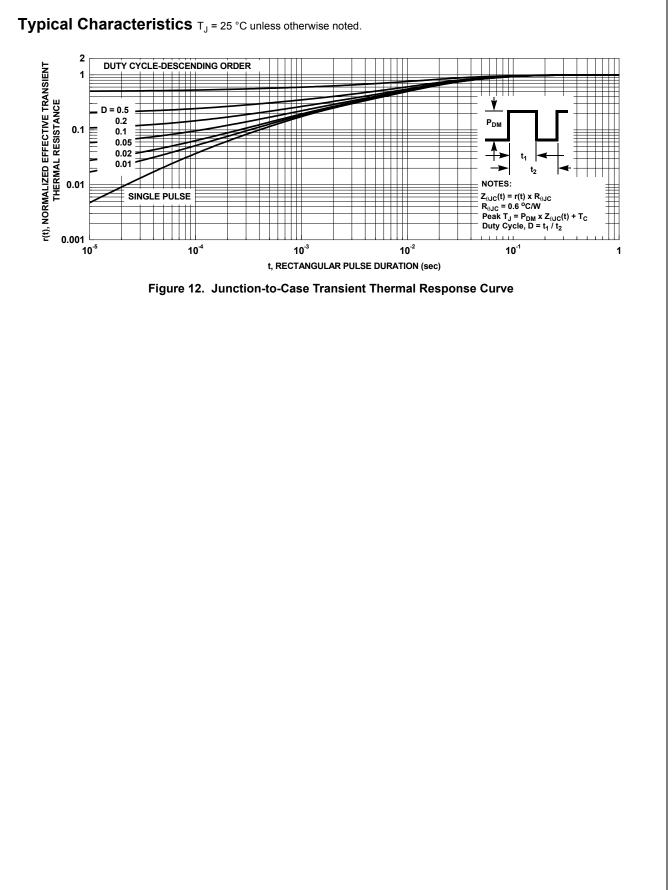
FDBL0260N100 N-Channel PowerTrench[®] MOSFET



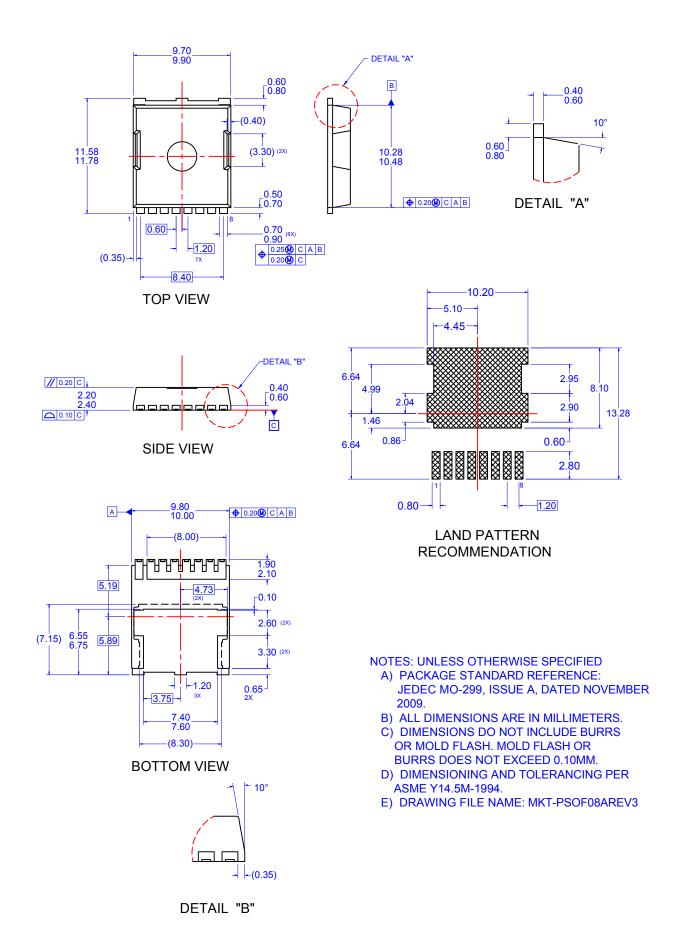
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FDBL0260N100 N-Channel PowerTrench[®] MOSFET





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